Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/696,300	WU ET AL.	
Examiner	Art Unit	
Alain L. Bashore	1762	

	SEAR	CHED	
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
427	8,425,162	8/8/2007	AB	
427	240	8/8/2007	AB	
118	715	8/8/2007	ab	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
previous search updated	8/8/2007	ab	
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